5.0±0.5

13.0<u>±0</u>.5

10.9±0.5

4.0±0.1

\$3.2±0.1

1.1±0.1

5.45±0.3

unit: mm

4.5±0.2

2.0±0.1

1.4±0.3

0.6±0.2

1. Gate

2: Drain

3: Source EIAJ: SC-65(a)

2SK1613

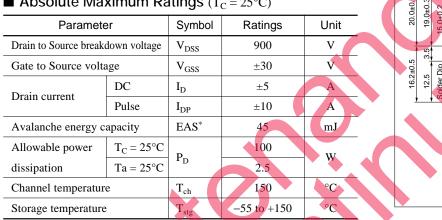
Silicon N-Channel Power F-MOS FET

Features

- High avalanche energy capacity
- V_{GSS}: 30V guaranteed
- Low R_{DS(on)}, high-speed switching characteristic

Applications

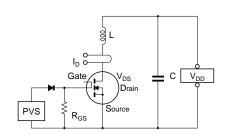
- High-speed switching (switching power supply)
- For high-frequency power amplification
- Absolute Maximum Ratings ($T_C = 25^{\circ}C$)

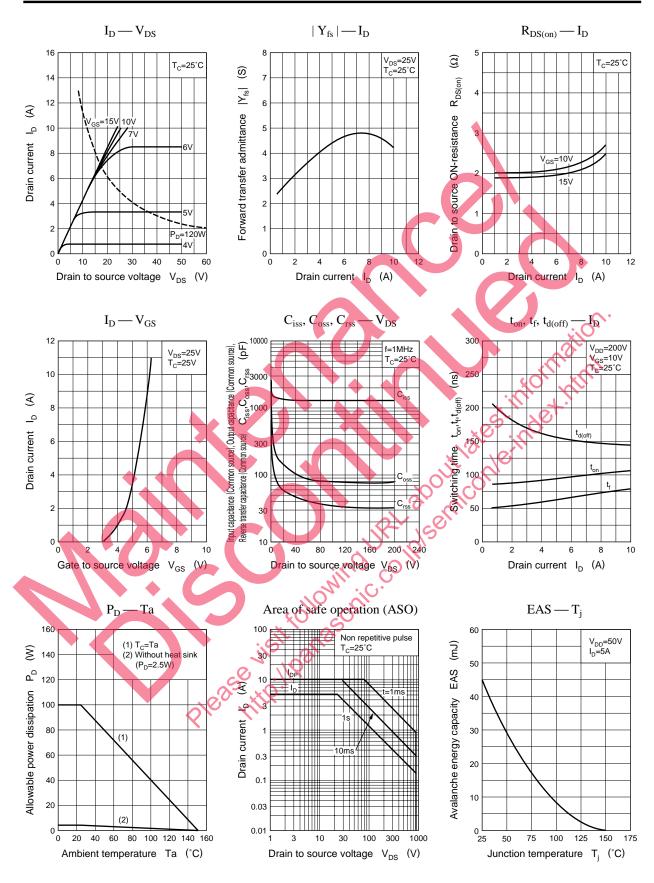


Electrical Characteristics ($T_c = 25^{\circ}C$)

Channel temperature	T _{ch}	150 °C		at III		J: SC-65(a) Package (a)
Storage temperature	T _{stg}	-55 to +150 °C	X	0.0	0	
* Single pulse			it la	10		
Electrical Characteristics ($T_c = 25^{\circ}C$)						
Parameter	Symbol	Conditions	min	typ	max	Unit
Drain to Source cut-off current	I _{DSS}	$V_{\rm DS} = 720 V, V_{\rm GS} = 0$	0		0.1	mA
Gate to Source leakage current	I _{GSS}	$V_{GS} = \pm 30V, V_{DS} = 0$	0		±1	μΑ
Drain to Source breakdown voltage	V _{DSS}	$I_D = 1 mA, V_{GS} = 0$	900			V
Avalanche energy capacity	EAS*	$L = 3.6 \text{mH}, I_D = 5 \text{A}, V_{DD} = 50 \text{V}$	45			mJ
Gate threshold voltage	V _{th}	$V_{\rm DS} = 25V, I_{\rm D} = 1 {\rm mA}$	2		5	V
Drain to Source ON-resistance	R _{DS(on)}	$V_{GS} = 10V, I_D = 3A$		2	2.8	Ω
Forward transfer admittance	Y _{fs}	$V_{DS} = 25V, I_D = 3A$	1.5	3.5		S
Input capacitance (Common Source)	C _{iss}	1,00		1400		pF
Output capacitance (Common Source)	Coss	$V_{DS} = 20V, V_{GS} = 0, f = 1MHz$		140		pF
Reverse transfer capacitance (Common Source)	C _{rss}	ALC A		60		pF
Turn-on time	t _{on}	$V_{GS} = 10V, I_D = 3A$		90		ns
Fall time	t _f	$V_{GS} = 10V, I_D = 5A$ $V_{DD} = 200V, R_I = 66\Omega$		60		ns
Turn-off time (delay time)	t _{d(off)}	$v_{\rm DD} = 200 v$, $\kappa_{\rm L} = 0.032$		170		ns

* Avalanche energy capacity test circuit





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